Centro Federal de Educação Tecnológica de Santa Catarina
Departamento Acadêmico de Eletrônica
Conversores Estáticos

Semicondutores Aplicados a Conversores CA-CA (IGBTs e MOSFETs)

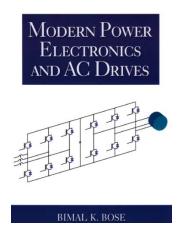
Prof. Clóvis Antônio Petry.

Florianópolis, março de 2008.

Bibliografia para esta aula

Capítulo 3: Transistores de potência

1. Semicondutores aplicados a conversores CA-CA.













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Nesta aula

Semicondutores aplicados a conversores CA-CA:

- 1. Introdução;
- 2. Revisão dos principais componentes semicondutores de potência;
- 3. MOSFET de potência;
- 4. IGBT;
- 5. Comparativo BJT x MOSFET x IGBT.

Quadrantes de condução de semicondutores

Operações Básicas Desejadas

Operação em um quadrante

- Diodos (bloqueio reverso)
- SCR (bloqueio direto)
- Transistor Bipolar
- IGBT

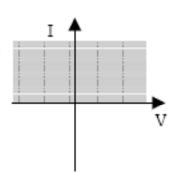
Operação em dois quadrantes com corrente bidirecional

- MOSFET
- SCR + diodo em antiparalelo
- IGBT + diodo em antiparalelo
- Transistor Bipolar + diodo em anti-paralelo

V

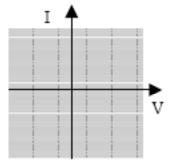
Operação em dois quadrantes com tensão bidirecional

- SCR (bloqueio direto e reverso)
- Transistor Bipolar + diodo em série



Operação em quatro quadrantes

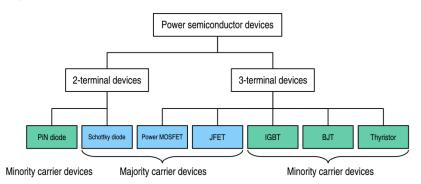
 Arranjo de diodos com transistores bipolares



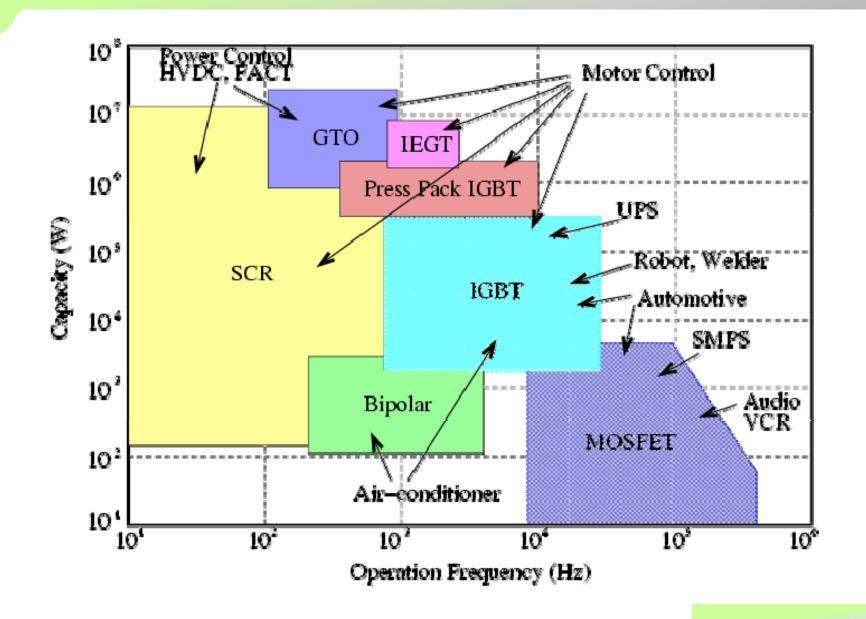
Semicondutores para eletrônica de potência

Semicondutores utilizados em eletrônica de potência:

- Diode
- Thyristor or silicon-controlled rectifier (SCR)
- Triac
- Gate turn-off thyristor (GTO)
- Bipolar junction transistor (BJT or BPT)
- Power MOSFET
- Static induction transistor (SIT)
- Insulated gate bipolar transistor (IGBT)
- MOS-controlled thyristor (MCT)
- Integrated gate-commutated thyristor (IGCT)



Semicondutores para eletrônica de potência



Semicondutores para eletrônica de potência

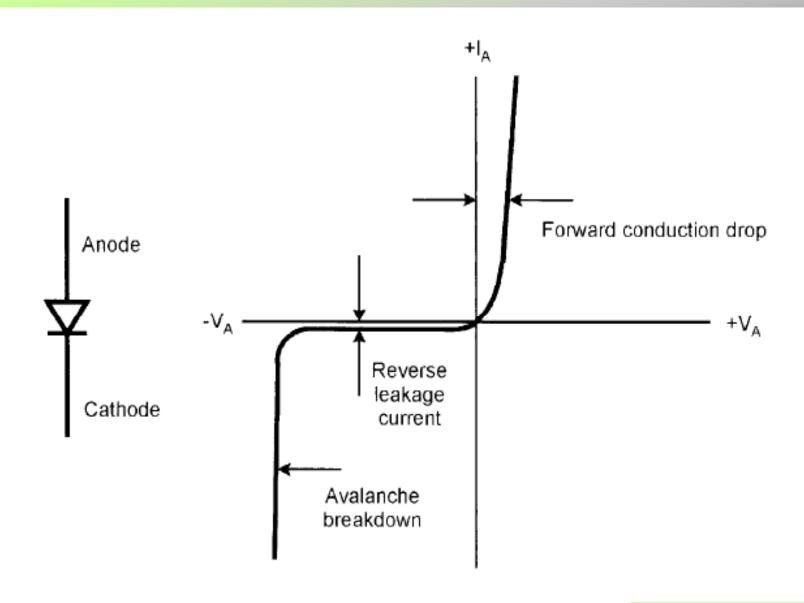




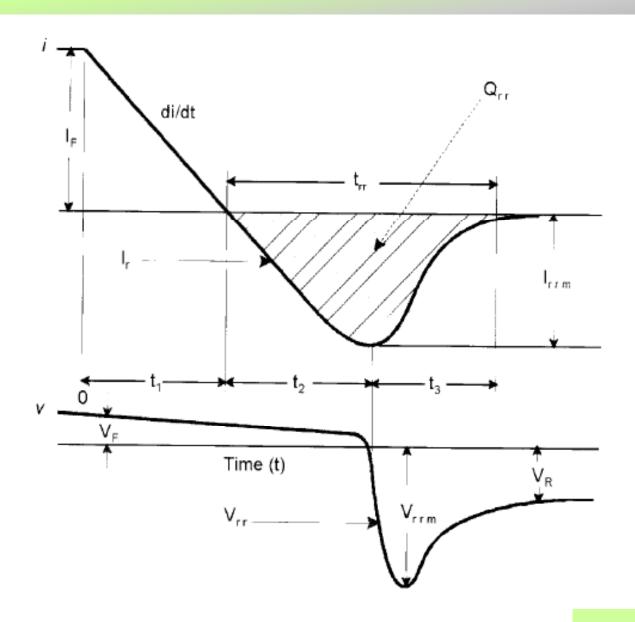




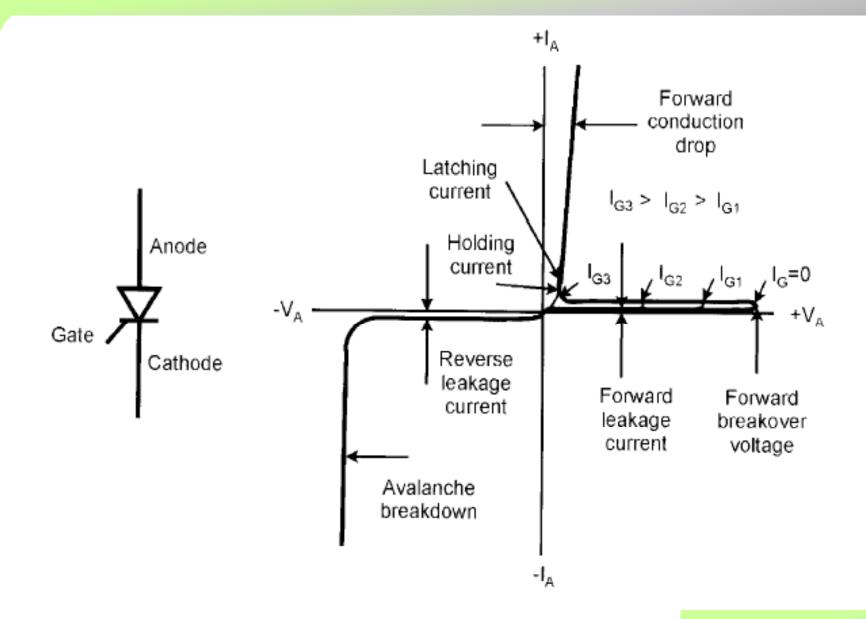
Revisão - Diodos



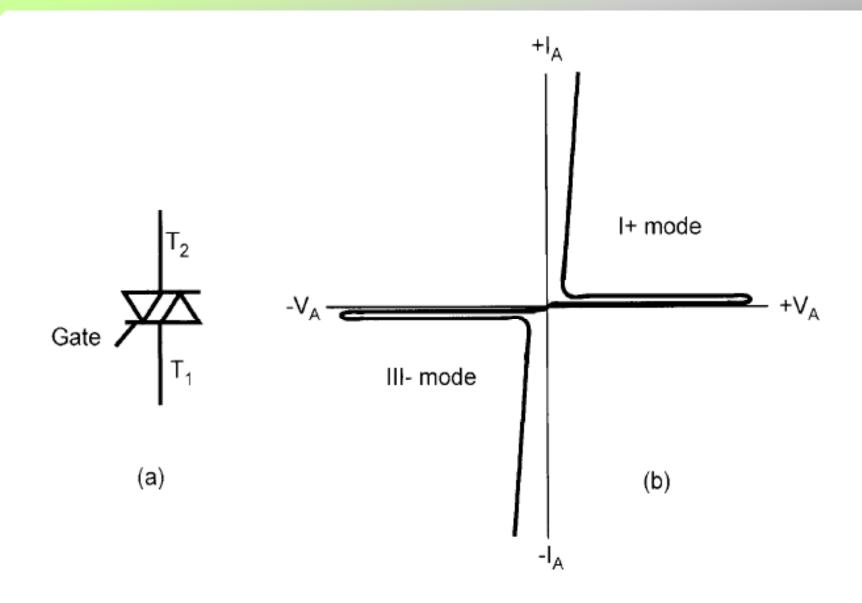
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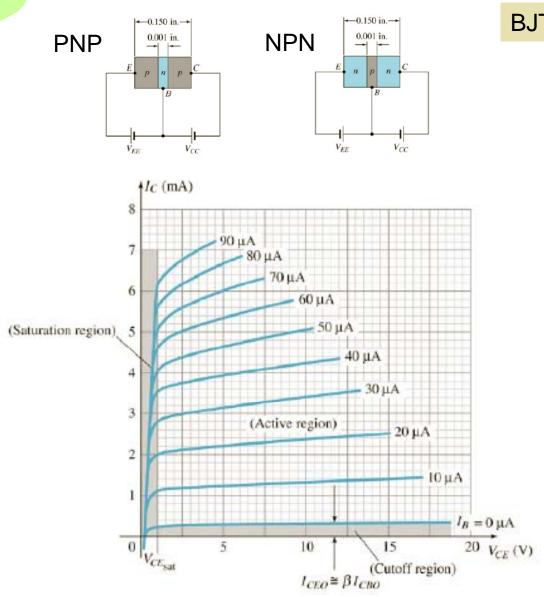


Revisão - Tiristores



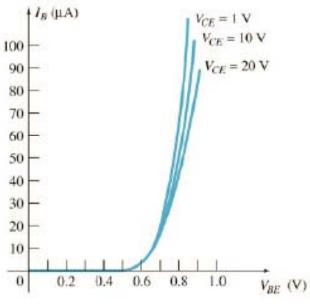
Revisão - Tiristores

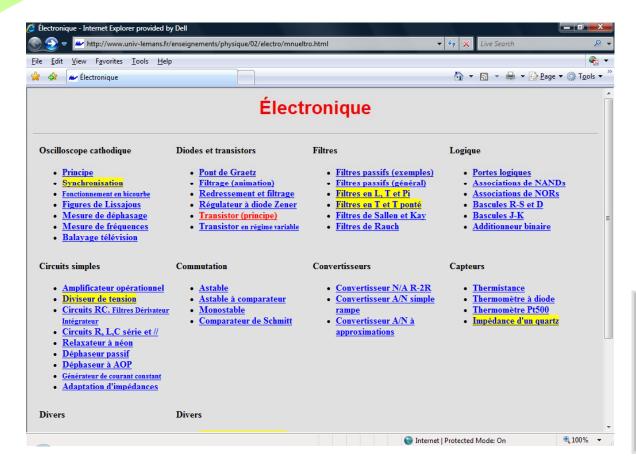


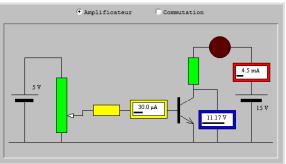


BJT – Transistor bipolar de junção

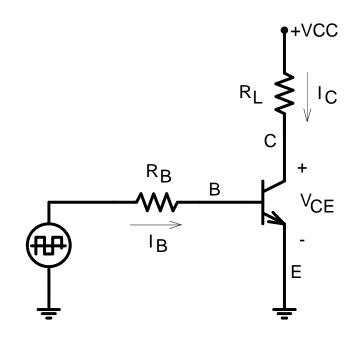






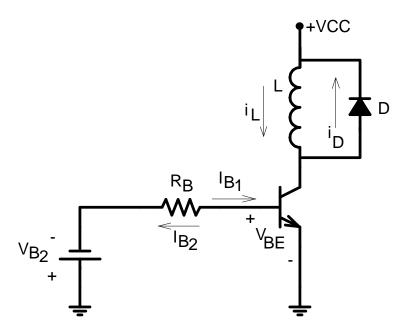


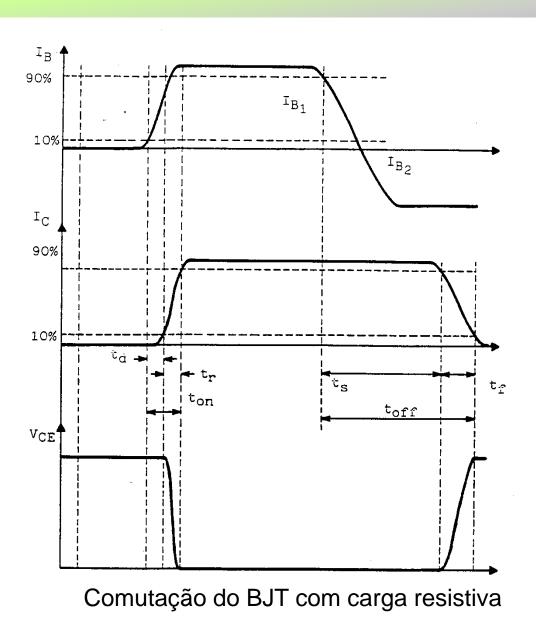
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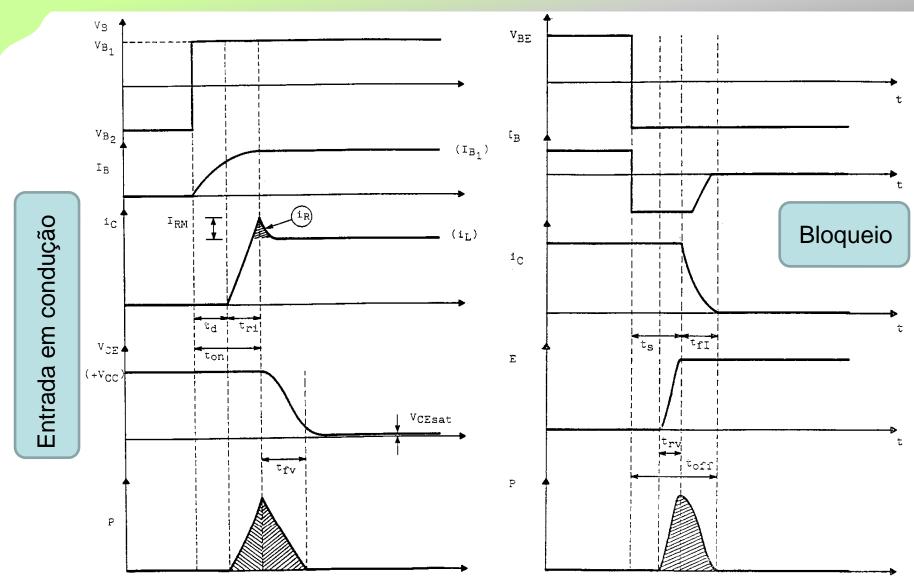


Comutação do BJT com carga resistiva

Comutação do BJT com carga indutiva



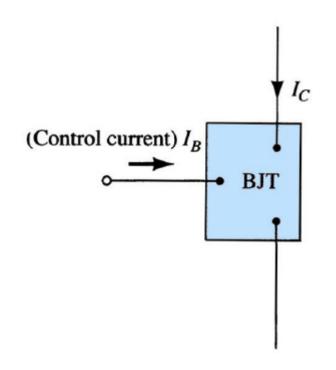


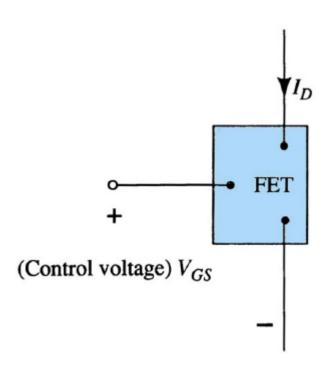


Comutação do BJT com carga indutiva

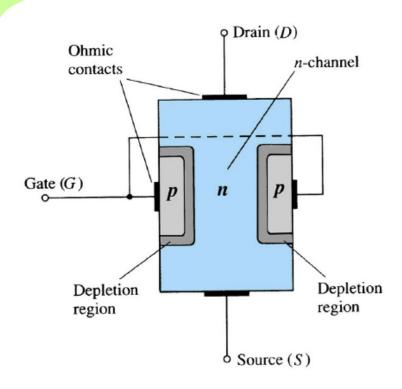
BJT x FET

FET – Transistor de efeito de campo

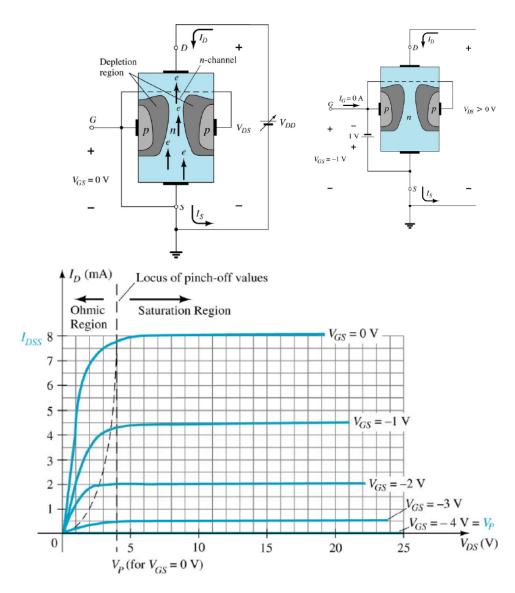




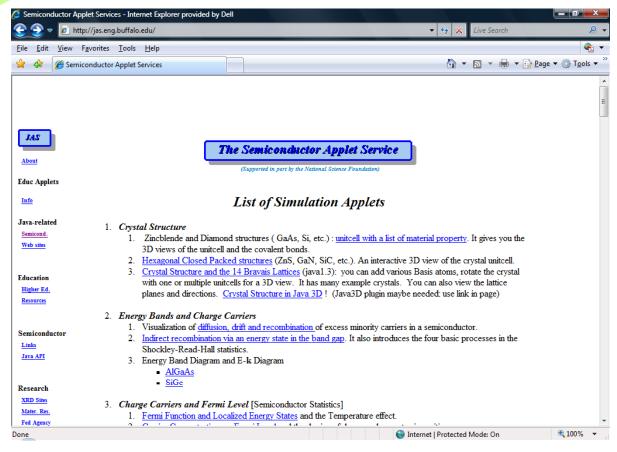
FET



JFET: Operação básica.

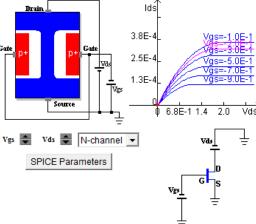


FET

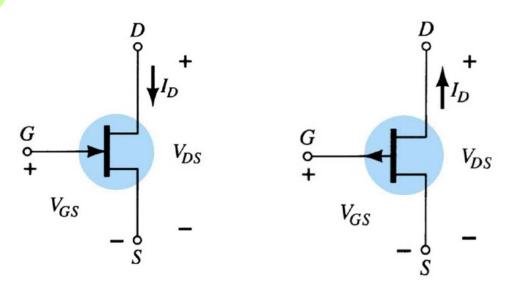


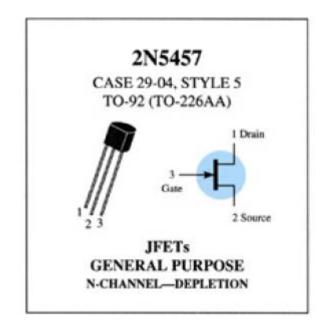
http://jas.eng.buffalo.edu/





FET

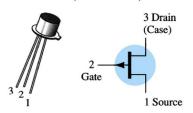




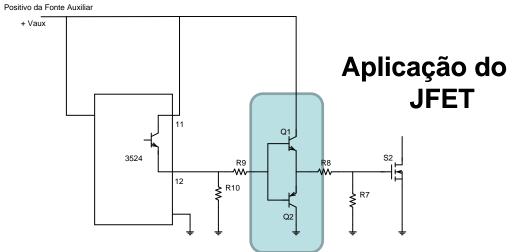
JFET canal n e canal p

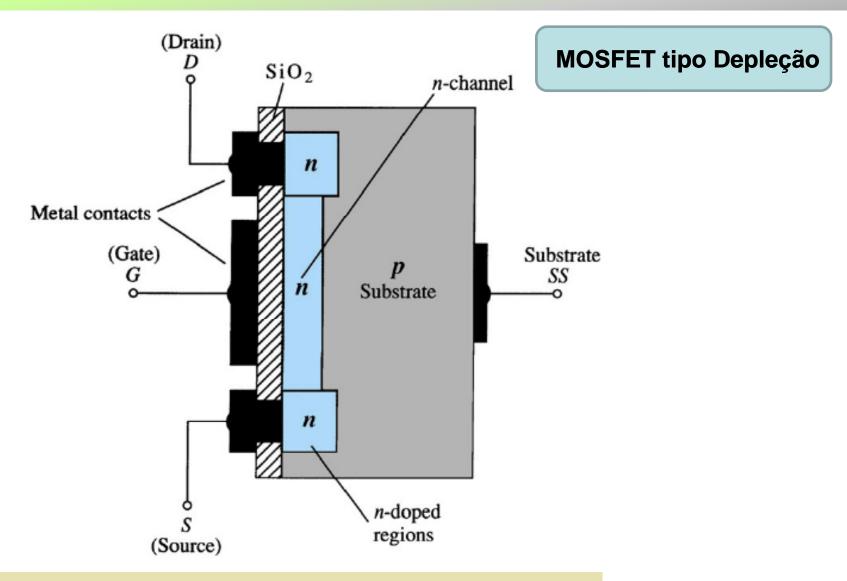
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CASE 22-03, STYLE 12 TO-18 (TO-206AA)

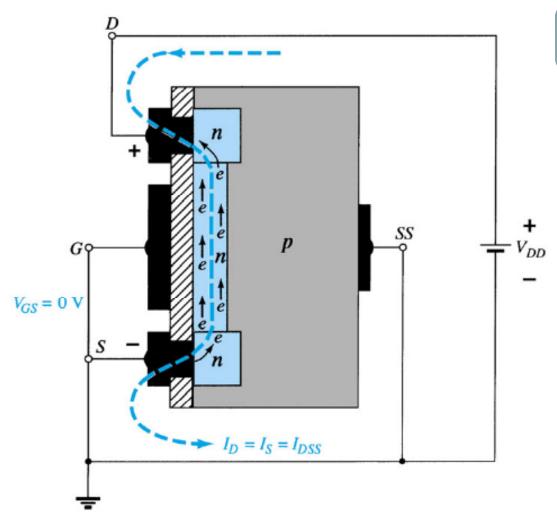


JFETs GENERAL PURPOSE P-CHANNEL



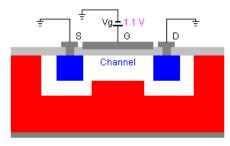


MOSFET – Metal Oxide Semiconductor Field Effect Transistor



MOSFET: Operação básica.

MOSFET tipo Depleção



Enhancement-mode (Normally-off) MOSFET

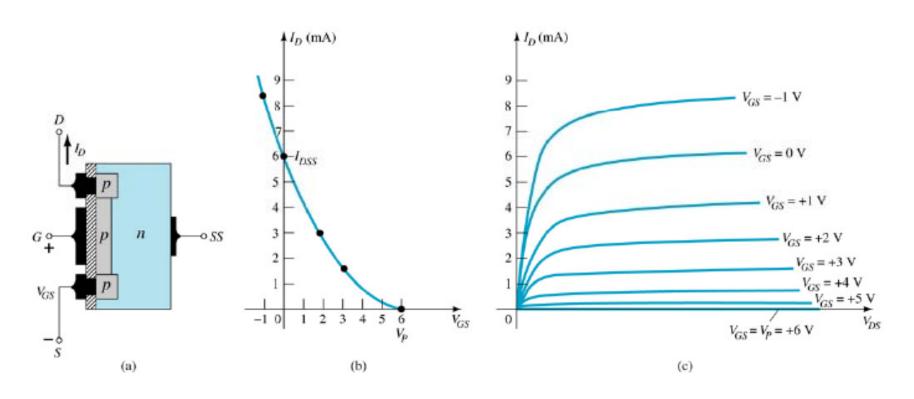
N-channel

Vg > Vt: gate bias is more positive than the threshold voltage. Sufficient electrons accumulate and forms the inversion channe



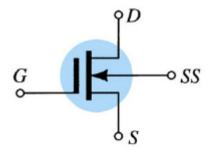
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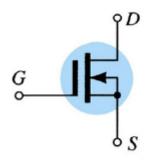
MOSFET tipo Depleção



MOSFET: Operação básica.

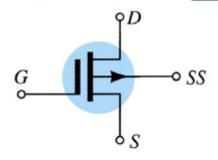
n-channel

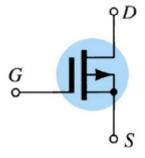


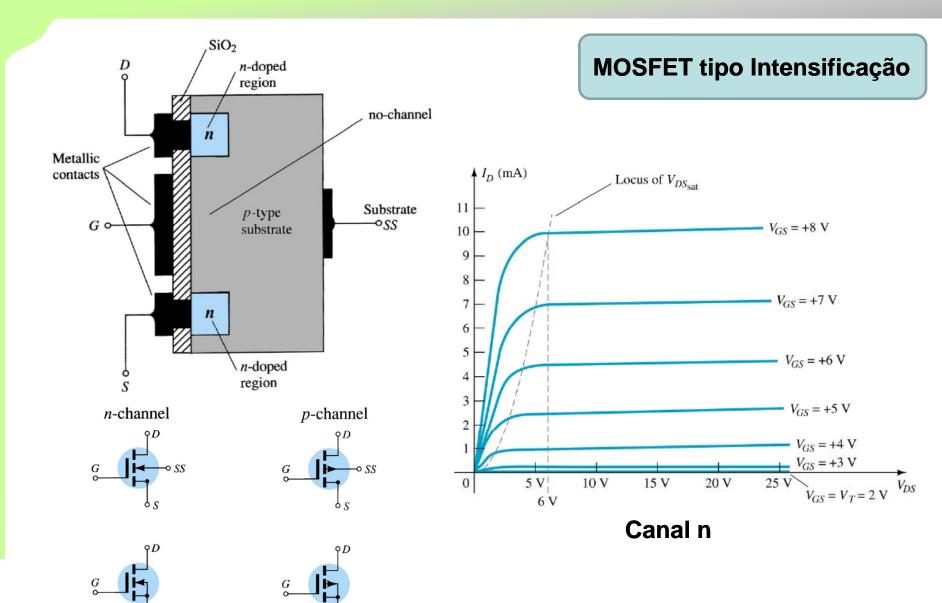


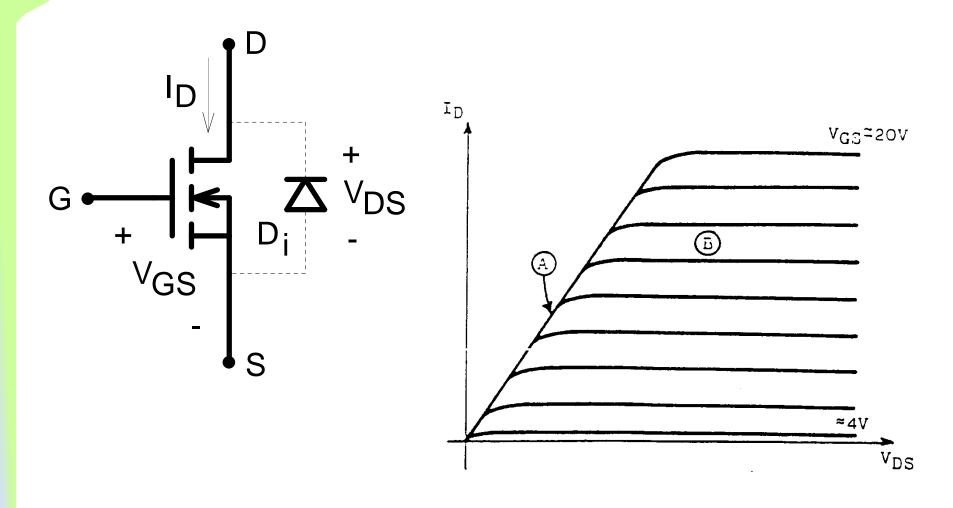
p-channel

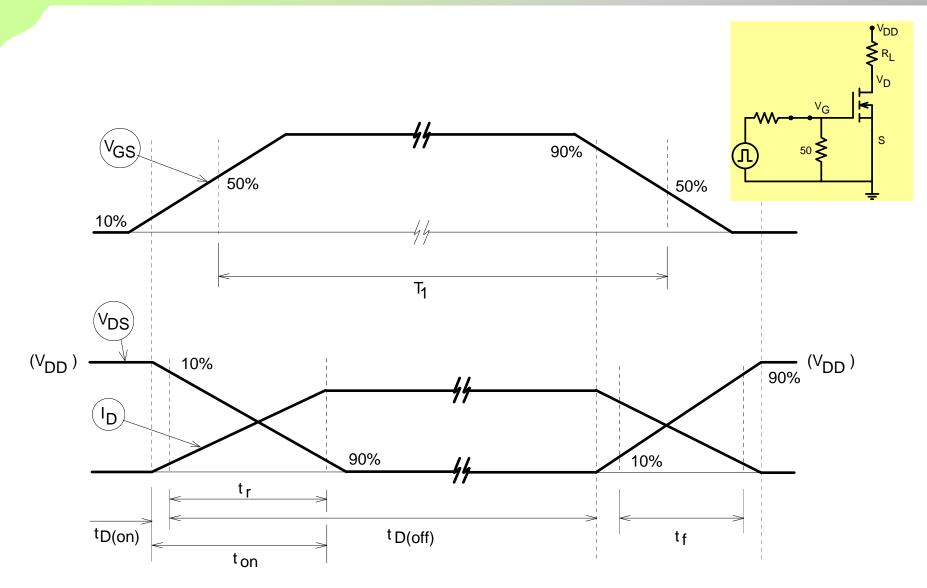
MOSFET tipo Depleção



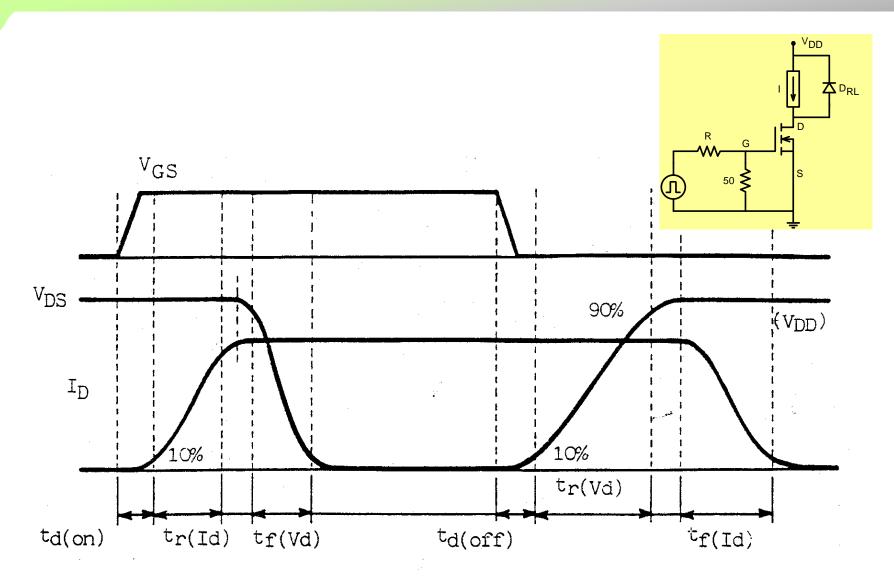








Comutação do MOSFET com carga resistiva



Comutação do MOSFET com carga indutiva

Classificação das perdas:

1. Condução;

$$P_{cond} = \frac{t_{on}}{T} \cdot r_{ds(on)} \cdot i_{d(on)}^{2}$$

- 2. Comutação:
 - Entrada em condução e bloqueio;

$$P_{com} = \frac{f}{2} \left(t_r + t_f \right) \cdot i_{d(on)} \cdot v_{ds(off)}$$

Onde:

$$t_f \cong t_{on}$$
 $t_r \cong t_{off}$

$$t_r \cong t_{off}$$

Dados de catalogo:

International **TOR** Rectifier

PD - 94459A

IRFP150V

HEXFET® Power MOSFET

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated



 $V_{DSS} = 100V$ $R_{DS(on)} = 24m\Omega$ $I_D = 47A$

Description

Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the tast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designar with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels practude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.



Absolute Maximum Ratings

	Parameter	Max.	Units
Ip @ To = 25°C	Continuous Drain Current, V _{GS} @ 10V	48	
I _D & T _C = 100°C		32	
IDM	Pulsed Drain Current ©	230	
Po@To=25°C	Power Dissipation	140	w
	Linear Dentiling Factor	0.91	W.c
V _{GS}	Gate-to-Source Voltage	± 20	V
I _{AR}	Avalanche Current©	28	Α.
EAR	Repetitive Avalanche Energy®	20	III.J
d v/dt	Peak Diode Recovery dv/dt ⊕	5.8	Wns
T,	Operating Junction and	-65 to +175	
T _{STG}	Storage Temperature Pange		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	┑
	Mounting torque, 6-32 or M3 snew	10 lbf-in (1.1 N-m)	

Thermal Resistance

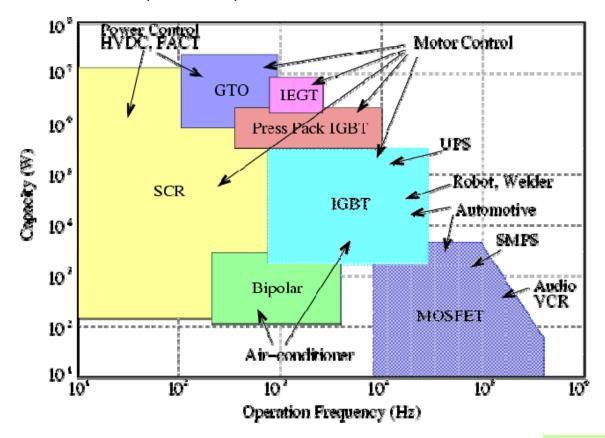
	Parameter	Тур.	Max.	Units
R _{WC}	Junction-to-Case	_	1.1	
Recs	Case-to-Sink, Flat, Greased Surface	0.24	_	°C/W
Revia	Junction-to-Ambient	_	40	

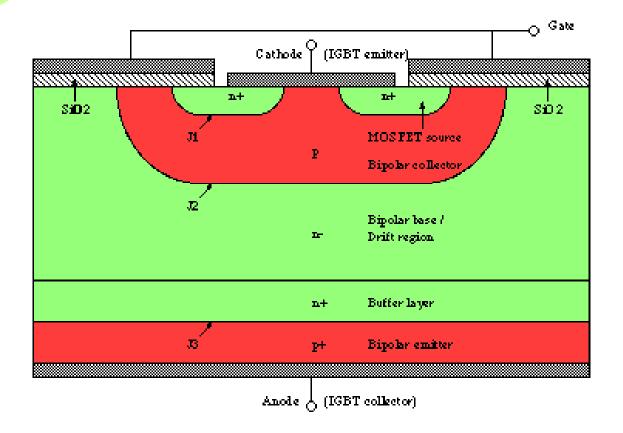
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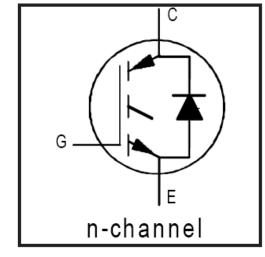
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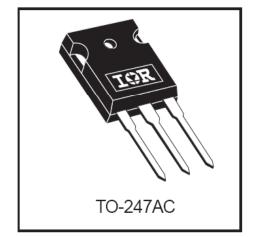
Quando usar MOSFET:

- 1. Freqüências altas (acima de 50 kHz);
- 2. Tensões muito baixas (< 500 V);
- 3. Potências baixas (< 1 kW).









Características de BJT e MOSFET

IGBT – Insulated Gate Bipolar Transistor

Classificação das perdas:

1. Condução;

$$P_{cond} = (i_C \cdot V_{CEsat} + i_B \cdot V_{BEsat}) \cdot t_{on} \cdot f$$

- 2. Comutação:
 - Entrada em condução e bloqueio;

$$P_{com} = \frac{1}{2} \left(t_r + t_f \right) \cdot I \cdot E \cdot f$$

Detalhamento do cálculo de perdas

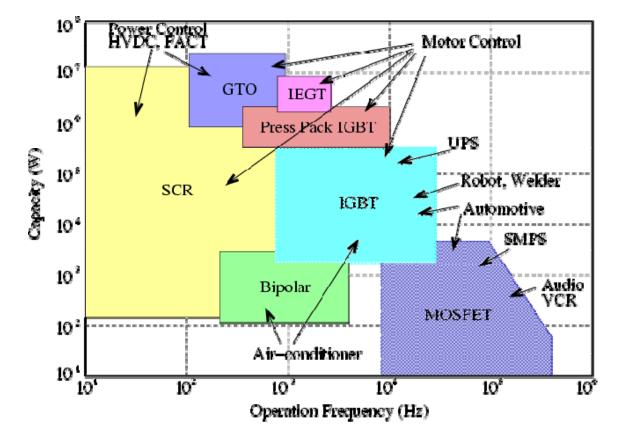




Quando usar IGBT:

- Freqüências baixas (menor que 50 kHz);
- 2. Tensões altas (> 500 V);
- 3. Potências altas (> 1 kW).

Part	Family	Package	Circuit	Switching Speed
▲ ▼	**	A T	A T	
IRG4PH30K	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 4-20 kHz
IRG4PC20U	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 8-60 kHz
IRG4PC30S	IGBT Discretes	TO-247AC	Discrete	DC-1 kHz (STANDARD)
IRG4PC60U	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 8-60 kHz
IRG4BC30W	IGBT Discretes	TO-220AB	Discrete	WARP 60-150 kHz
IRGB30BG0K	IGBT Discretes	TO-220AB	Discrete	ULTRAFAST 10-30 kl iz
IRGB8B60K	IGBT Discretes	TO-220AB	Discrete	ULTRAFAST 10-30 kHz
IRGS6B60K	IGBT Discretes	D2-Pak	Discrete	ULTRAFAST 10-30 kHz
IRGS14C40L	IGBT Discretes	D2-Pak	Discrete	Low-Vceon
IRGP4050	IGBT Discretes	TO-247AC	Discrete	Low-Vceon



Quando usar IGBT:

- 1. Freqüências baixas (menor que 50 kHz);
- 2. Tensões altas (> 500 V);
- 3. Potências altas (> 1 kW).



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Part	Family	Package	Circuit	Switching Speed	VCES (V)	VCE(ON) (V)	IC @ 25C (A)	IC @ 100C (A)	PD @25C (W)
A ¥	**	A ¥	* *	**	A T	A ¥	* *	**	**
IRG4PH30K	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 4-20 kHz	1200	4.20	20	10	100
IRG4PC20U	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 8-60 kHz	600	2.1	13	6.5	60
IRG4PC30S	IGBT Discretes	TO-247AC	Discrete	DC-1 kHz (STANDARD)	600	1.60	34	18	100
IRG4PC60U	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 8-60 kHz	600	2.00	75	40	520
IRG4BC30W	IGBT Discretes	TO-220AB	Discrete	WARP 60-150 kHz	600	2.70	23	12	100
IRGB30B60K	IGBT Discretes	TO-220AB	Discrete	ULTRAFAST 10-30 K HZ	600	2.35	78	50	370
IRGB8B60K	IGBT Discretes	TO-220AB	Discrete	ULTRAFAST 10-30 kHz	600	2.2	17	9.0	140
IRGS6B60K	IGBT Discretes	D2-Pak	Discrete	ULTRAFAST 10-30 kHz	600	1.80	13	7	90
IRGS14C40L	IGBT Discretes	D2-Pak	Discrete	Low-Vceon	430	1.40	20	14	125
<u>IRGP4050</u>	IGBT Discretes	TO-247AC	Discrete	Low-Vceon	250	1.90	104	56	330

Encapsulamentos:



www.semikron.com.br





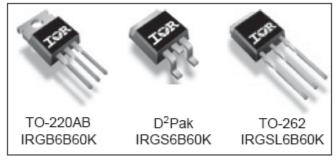


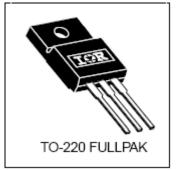


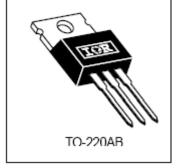


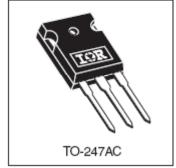
Encapsulamentos:









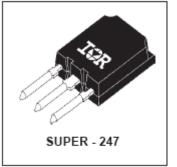




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Dados de catalogo:

International IOR Rectifier

IRG4PC60U

PD - 94443

INSULATED GATE BIPOLAR TRANSISTOR

UltraFast Speed IGBT

Features

- · UltraFast: Optimized for high operating frequencies up to 50 kHz in hard switching. >200 kHz in resonant mode.
- · Generation 4 IGBT design provides tighter parameter distribution and higher efficiency.
- Industry standard TO-247AC package.



V_{CES}=600V $V_{CE(an) typ.} = 1.6V$ @Vgg = 15V, lo = 40A

Benefits

- Generation 4 IGBT's offer highest efficiency available.
- . IGBT's optimized for specified application conditions.
- . Designed for best performance when used with IR. Hexfred & IR Fred companion diodes.



Absolute Maximum Ratings

	Parameter	Max.	Units
Vces	Collector-to-Emitter Breakdown Voltage	600	V
le@Te=25°C	Continuous Collector Current	75	
le @ Te = 100°C	Continuous Collector Current	40	A
lear	Pulsed Collector Current Φ	300]
lui	Clamped Inductive Load Current®	300	1
VoE	Gate-to-Emitter Voltage	± 20	V
EARN	Reverse Voltage Avalanche Energy ©	200	mJ
Pp @ Tc = 25°C	Maximum Power Dissipation	520	w
Pp @ Tc = 100°C	Maximum Power Dissipation	210	1 "
T _J	Operating Junction and	-55 to + 150	
Тата	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (0.063 in. (1.6mm from case)	1
	Mounting torque, 6-32 or M3 screw.	10 lbf-in (1.1N-m)	

Thermal Resistance

	Parameter	Typ.	Max.	Unitis
Reuc	Junction-to-Case		0.24	
Rece	Case-to-Sink, Flat, Greased Surface	0.24		°CW
Rea.	Junction-to-Ambient, typical socket mount		40	
Wt	Weight	6 (0.21)		g (oz)

www.inf.com 04/25/02

International IOR Rectifier

IRG4PC40UD

UltraFast CoPack IGBT INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE

Features

- · UltraFast: Optimized for high operating frequencies 8-40 kHz in hard switching, >200 kHz in resonant mode
- . Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than Generation 3
- IGST co-packaged with HEXFREDTM ultrafast. ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-247AC package

- · Generation -4 IGBT's offer highest efficiencies
- · IGBT's optimized for specific application conditions . HEXFRED diodes optimized for performance with
- IGBT's . Minimized recovery characteristics require lessino snubbing
- Designed to be a "drop-in" replacement for equivalent. Industry-standard Generation 3 IR IGBT's Absolute Maximum Ratings







PD 9.1467D



	Parameter	Max.	Unite
Voss	Collector-to-Emitter Voltage	600	V
le @ Te = 25°C	Continuous Collector Current	40	\neg
le @ Te = 100°C	Continuous Collector Current	20	7
leu	Pulsed Collector Current ©	160	A
LM	Clamped Inductive Load Current Ø	160	\Box
le @ Tc = 100°C	Diode Continuous Forward Current	15	7
Ira	Diode Maximum Forward Current	160	
Vax	Gate-to-Emitter Voltage	± 20	V
Pp @ Tc = 25°C	Maximum Power Dissipation	160	w
Po @ To = 100°C	Maximum Power Dissipation	65	**
Tj	Operating Junction and	-55 to +150	
Tana	Storage Temperature Range		*C
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting Torque, 6-32 or M3 Screw.	10 Réin (1.1 Nem)	\neg

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Unite	
Raic	Junction-to-Case - IGBT			0.77		
Raic	Junction-to-Case - Diode			1.7	"CAV	
Rece	Case-to-Sink, flat, greased surface		0.24]	
Raix	Junction-to-Ambient, typical socket mount	İ	İ	40	1 1	
Wt	Weight		6 (0.21)		g (oz)	

4/17/97

BJT x MOSFET x IGBT

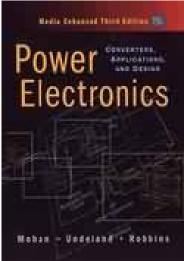
	MOSFET	IGBT	BJT
Tipo de comando	Tensão	Tensão	Corrente
Potência do comando	Mínima	Mínima	Grande
Complexidade do comando	Simples	Simples	Média
Densidade de corrente	Elevada em baixas tensões e Baixa em altas tensões	Muito elevada	Média
Perdas de comutação	Muito baixa	Baixa para Média	Média para Alta

Próxima aula

Conversores CA-CA:

1. Gradadores.





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